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Indium Tin Oxide Modified by Au and Vanadium Pentoxide as an Efficient Anode for Organic Light-Emitting Devices

H. M. Zhang and Wallace C. H. Choy, Senior Member, IEEE

Abstract—Au/Vanadium pentoxide ($V_2O_5$) films on indium tin oxide (ITO) as composite anodes for hole injection in organic light-emitting devices (OLEDs) have been investigated. The device with ITO/Au (6 nm)/$V_2O_5$ (6 nm) anode shows improved current density–voltage characteristics as compared with the device with ITO/Au as anode. Hole injection is significantly reduced when Au was added on ITO as an anode. However, while a thin $V_2O_5$ film is deposited on a Au anode, the barrier height is substantially reduced. The hole injection is facilitated, and the driving voltage is decreased by 10 V. In addition, the maximum current density of the device decreased by 10 V. Moreover, the incorporation of injection enhancing interlayer (ITO–Au–$V_2O_5$) film as a composite hole-injection layer on ITO anode for bottom emitting OLEDs shows improved current efficiency ($\sim$3.5 cd/A) and ITO/$V_2O_5$ OLED of $\sim$2.8 cd/A.

Index Terms—Efficient anode, improved hole injection, organic light-emitting devices (OLEDs), reduced driving voltage.

Conventional bottom emitting organic light-emitting devices (OLEDs) commonly use conductive indium tin oxide (ITO) as anode because of its high conductivity, transparency, and work function. However, the surface of ITO glass is chemically and physically ill defined, which will degrade the performance as the hole-injecting electrode in OLEDs. Over the past years, many methods were used to treat the surface of ITO to increase the work function [1]–[5], such as ultraviolet–ozone cleaning and oxygen plasma exposure, in order to enhance hole injection [1], [2]. These treatments were effective in removing residual surface contaminants and increasing oxygen content at ITO surface, resulting in the increase of work function to minimize interfacial charge injection barriers.

Moreover, the incorporation of injection enhancing interlayer at electrode–organic interfaces has been used as one alternative route to control carrier injection [6], [7]. Using metal oxides with high work function, such as Ag$_2$O [8] and NiO$_x$ [9], as an interfacial layer between ITO and organic material has been proven to enhance hole-injection efficiencies. Vanadium pentoxide ($V_2O_5$) is a $p$-type semiconductor [10] with a high work function of $\sim$5.4 eV [11]. It has also been used as an efficient modification layer of ITO and (p-Si) anode to enhance hole injection [12], [13]. In addition, many high work function metals such as Ag and Au [14], [15] have been studied as the anode materials. However, they are not suitable for the anode as the hole injection is virtually blocked when the metal anodes are used [16]–[18]. The reports generally concluded that the performance of OLEDs with metal anodes is poorer than those OLEDs with ITO anodes. However, the metals of Au and Pt with proper surface treatment on non-ITO electrodes, such as Si and Al, have been reported to improve the performance of top emission OLEDs [19], [20] but no obvious studies on ITO electrodes for bottom emission OLEDs. In this brief, we use $V_2O_5$ coating on transparent thin Au film as a composite hole-injection layer on ITO anode for bottom emitting OLEDs. The characteristics of bottom emitting OLEDs with the composite anodes of ITO–Au–$V_2O_5$ are described.

The thin oxide layer $V_2O_5$ is used to modify the surface of Au for enhancing the hole injection from Au by the increase of work function to 5.3 eV and thus sequentially improves emission efficiency. The effects of $V_2O_5$ layer on the enhancement of electrical properties of the bottom emitting OLEDs are discussed. Ultraviolet and X-ray photoelectron spectroscopy (UPS and XPS, respectively) analysis indicate that the higher work function of ITO/Au/$V_2O_5$ (5.3 eV) than ITO/Au (5.0 eV) anode is due to Au surface band bending. Thus, the barrier for hole injection from ITO through Au/$V_2O_5$ to the hole transport layer (HTL) is decreased. Our results show that the performance of OLEDs with $V_2O_5$ layer is greatly improved compared with the case of only Au layer on the ITO. Interestingly, it is also better than the ITO anode modified by $V_2O_5$ device.

All devices were fabricated on ITO coated glass with a sheet resistance of 10 $\Omega/\square$, and thermally deposited LiF/Al was used as cathode. ITO substrate was cleaned and treated by O$_2$ plasma. The deposition was carried out at a pressure of less than $3 \times 10^{-4}$ Pa without any vacuum break. The organics and metal oxide were evaporated at the rate in a range of 0.3–0.4 nm/s. The Au metals were evaporated at the rate of $\sim$0.1 nm/s prior to the oxide and organic layer deposition. Metal was evaporated at the rate of 0.3–0.5 nm/s. The devices have an emissive area of 3.57 mm$^2$. The organic layers consisted of 70-nm 4,4′-N,N′-bis[N-(1-naphthyl)-N-phenyl-amino]...
biphenyl (NPB) as the HTL, 50-nm tris(8-hydroxyquinoline) aluminum (Alq3) as the electron transport layer, and emissive layer. The bilayer of LiF/Al was used as the efficient electron injection cathode. The structure of the device is ITO/Au(6 nm)/V2O5(5 nm)/NPB(70 nm)/Alq3(50 nm)/LiF(1 nm)/Al(70 nm). For comparison, another three devices were fabricated. These three devices had the same organic and electron injection structure as the one just described, except that Au on the ITO without V2O5 coating, ITO coated with V2O5, and bare ITO were used as the anodes.

The current–voltage-brightness characteristics were recorded using a computer controlled source meter (Keithley 2400) and photometer (IL1400A) with a calibrated silicon photodiode. The EL spectra were measured by Instaspec spectrometer. All measurements were carried out in ambient atmosphere at room temperature. The UPS of samples was measured with He discharge lamp (UV light of 21.2 V; Thermo Electron Corporation, ESCALAB 250). The XPS measurements were carried out with LargeAreaXL surface analysis system using a monochromatic Al K Alpha source.

The J–V characteristics of the four devices with ITO/Au/V2O5, ITO/Au, ITO/V2O5, and bare ITO anodes are shown in Fig. 1(a). The devices with the ITO/Au and bare ITO anodes show poor hole injection. However, by adding a layer of V2O5 with a thickness of 6 nm, the J–V characteristics of the device with ITO/V2O5 and ITO/Au/V2O5 anodes are dramatically improved as compared with the previous two OLED structures without V2O5. For example, the current density of OLEDs with the ITO/Au and ITO/Au/V2O5 anodes at 11 V are 0.065 and 69 mA/cm², respectively. Fig. 1(b) shows that, at the same applied voltage, the luminance of the OLED with the ITO/Au/V2O5 anode is much larger than that of the device with the ITO/Au anode. The driving voltage for a given current or a given luminance of the OLED with the ITO/Au/V2O5 anode is significantly decreased by ~10 V as compared with that of the ITO/Au OLED due to V2O5 layer modification.

The current efficiency versus the current density of OLEDs is shown in Fig. 1(c). It can be seen that the maximum current efficiency of the ITO/Au/V2O5 OLED (~3.5 cd/A) is three times more than that of the ITO/Au anode device (~1.1 cd/A). The results are attributed to the V2O5 modification layer. The existence of V2O5 increases the hole injection to HTL and thus increases the number of excitons at the interface of NPB/Alq3. At the same time, the optical transmittance of ITO/Au/V2O5 is higher than that of ITO/Au, as shown in Fig. 2, which is also one of the reasons for increasing the current efficiency. However, the optical transmittance of ITO/Au/V2O5 is lower than that of ITO/V2O5, as shown in Fig. 2; the current efficiency of the ITO/Au/V2O5 OLED (~3.5 cd/A) is still higher than ITO/V2O5 OLED (~2.8 cd/A). Together with the J–V results of the ITO/Au/V2O5 OLED, as discussed previously, the higher current efficiency of ITO/Au/V2O5 OLED than ITO/V2O5 OLED is attributed to the better charge balance [21]. Moreover, the improved current efficiency is not likely due to the microcavity effect [22] in the device with ITO/Au/V2O5 anode because there is no change in electroluminescence spectrum (not shown in this brief).

The reduction of operation voltage can be explained by lowering the barrier of hole injection from anode to HTL. The UPS was used to measure the work function. The UPS spectra of V2O5, Au, and Au/V2O5 on ITO, as well as bare ITO, are shown in Fig. 3. From the UPS spectra, the work function of ITO is determined to be 4.7 eV. This value is consistent with the commonly accepted values [23]. The measured work functions of the other ITO surfaces modified by V2O5, Au, and Au/V2O5 are 5.1, 5.0, and 5.3 eV, respectively. From these measured data, we observe that there are about 0.4- and 0.3-eV increases in the work functions of ITO and ITO/Au surfaces treated by V2O5, respectively. The results indicate that the barrier for hole injection from ITO/V2O5 and ITO/Au/V2O5 anodes is decreased. Meanwhile, although the work function of Au is higher that of bare ITO, the existence of an interface dipole at the Au–NPB interface results in a large hole-injection barrier of 1.35 eV, which virtually blocks the hole injection [18].
The XPS of ITO/Au cannot provide better hole injection, which is agreed with [18]. Modification effect on the ITO surface. Therefore, Au on ITO d except the additional peaks of Au 4f [Fig. 4(c)] is similar to that of bare ITO anode [Fig. 4(a)] except the additional Au 4f and Au 4f peaks. This implies that V2O5 buffer layer offers modification effects on ITO/Au surface. Due to the composite anode of ITO and Au formed, the energy level difference exists between the ITO (4.7 eV) and Au (5.0 eV) interface; the device with ITO/V2O5 anode exhibited better J–V performance than the one with ITO/Au/V2O5 anode. It is also possible that Au as a block layer that makes ITO/Au/V2O5 OLED has a better charge balance. Consequently, the current efficiency of the ITO/Au/V2O5 OLED (~3.5 cd/A) is higher than ITO/V2O5 OLED (~2.8 cd/A).

In summary, we show that ITO/Au/V2O5 composite electrode can be used as an effective anode for bottom emitting OLEDs. Hole injection is virtually blocked when Au is added on ITO as an anode. Interestingly, while an additional layer of V2O5 is introduced on Au surface, the hole injection is greatly enhanced. It is attributed to a lower energy level difference at the anode/organic interface. In addition, the device with ITO/Au/V2O5 as anode provides a better charge balance, which makes the current efficiency of the ITO/Au/V2O5 OLED (~3.5 cd/A) 1.25 times higher than that of the ITO/V2O5 OLED (~2.8 cd/A).

REFERENCES


H. M. Zhang, photograph and biography not available at the time of publication.

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